OPB816Z



Features:

- 0.20" (5.1 mm) wide gap, 0.61" (15.5 mm) deep slot
- Wire length 24" (609 mm) minimum, 26 AWG
- Dust protection
- Two mounting tabs



Description:

The OPB816Z slotted switch consists of an infrared emitting diode and an NPN silicon phototransistor mounted in an opaque housing with clear windows for dust protection. Switching of the phototransistor occurs whenever an opaque object passes through the slot.

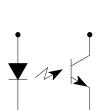
The OPB816Z has an 0.61'' (15.5 mm) deep slot allowing for a longer reach of the optical center line from the mounting plane. The phototransistor internal apertures are $0.010'' \times 0.06''$ (0.25 mm x 1.52 mm) on the sensor side ("S") and $0.05'' \times 0.06''$ (1.27 mm x 1.52 mm) on the emitter side ("E").

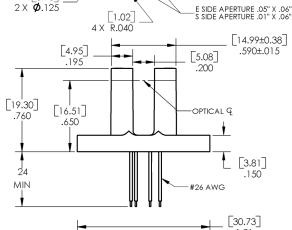
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Applications:

- Non-contact object sensing
- Assembly line automation
- Machine automation
- Equipment security
- Machine safety

Ordering Information			
Part Number	Description		
OPB816Z	Slotted switch		





[12.19]

[3.18]

Wire Color	or Description			
Red	Anode			
Black	Cathode			
Green	Emitter			
White	Collector			



[6.35]	[30.73] 1.21 [1.35±0.51] .053±.02 [1.35±0.51]	[MILLIMETERS]
[8.76±0.51]345±.02		INCHES

[3.18]

General Note





Electrical Specifications

Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Storage & Operating Temperature Range	-40°C to +85° C
Lead Soldering Temperature [1/16 inch (1.6mm) from the case for 5 sec. with soldering iron] (1)	260° C
Input Diode (see OP140 for additional information)	

Forward DC Current	50 mA
Peak Forward Current (1 μs pulse width, 300 pps)	3 A
Reverse DC Voltage	2 V
Power Dissipation ⁽²⁾	100 mW

Output Phototransistor (See OP552 for additional information)

Collector-Emitter Voltage	30 V
Emitter-Collector Voltage	5 V
Collector DC Current	30 mA
Power Dissipation ⁽²⁾	100 mW

Electrical Characteristics (T_A = 25°C unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
nput Diode (see OP140 for additional information)						
V_{F}	Forward Voltage	-	-	1.8	V	I _F = 20 mA
I _R	Reverse Current	-	-	100	μΑ	V _R = 2 V
Output Phototransistor (see OP552 for additional information)						
V _{(BR)(CEO)}	Collector-Emitter Breakdown Voltage	30	-	-	V	$I_C = 1 \text{ mA}, I_F = 0, E_E = 0$
$V_{(BR)(ECO)}$	Emitter-Collector Breakdown Voltage	5	-	-	V	$I_E = 100 \mu A$, $I_F = 0$, $E_E = 0$
I _{CEO}	Collector-Emitter Leakage Current	-	-	100	nA	$V_{CE} = 10 \text{ V}, I_F = 0, E_E = 0$
Coupled						
I _{C(ON)}	On-State Collector Current	1.0	-	10.0	mA	V _{CE} = 5 V, I _F = 20 mA

0.4

$V_{CE(SAT)}$ Notes:

- (1) RMA flux is recommended. Duration can be extended to 10 seconds maximum when flow soldering.
- (2) Derate linearly 1.67 mW/°C above 25° C.

Collector-Emitter

- All parameters are tested using pulse techniques. (3)
- Methanol or isopropanol are recommended as cleaning agents. Plastic housing is soluble in chlorinated hydrocarbons and ketones.
- Clear dust protection over emitter and sensor apertures.

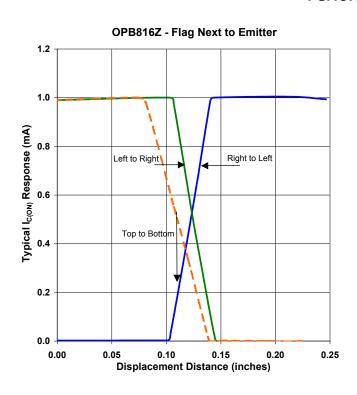
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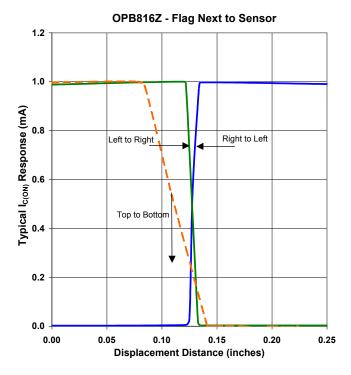
 $I_C = 100 \mu A$, $I_F = 20 mA$

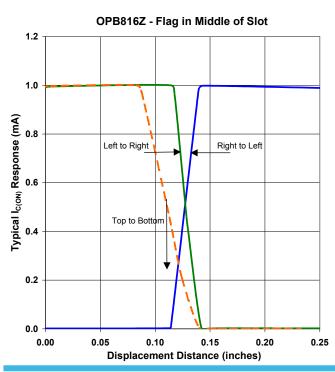
OPB816Z

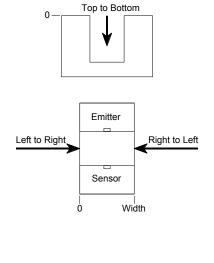


Performance









General Note

TT Electronics reserves the right to make changes in product specification without notice or liability. All information is subject to TT Electronics' own data and is considered accurate at time of going to print.





Issue	Change Description	Approval	Date
A	Initial Release		
A.1	Revised and put into new format. Required changes on all pages.	Steve Coble	12/07/05
A.1	Changed internal apertures in 2nd paragraph from 0.10" to 0.010" (R.Parks). Did not change revision number or issue date.		09/13/13